Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | WALTON ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0003155 A1	01-2004	Krontz, Jeoff M.	710/300
	В	US-2002/0099875 A1	07-2002	Locklear et al.	710/2
	С	US-2003/0126334 A1	07-2003	Brown et al.	710/301
	D	US-2002/0160743 A1	10-2002	Vianna et al.	455/349
	E	US-6,820,156 B1	11-2004	Miller et al.	710/301
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			·
	J	US-		*	
	к	US-		-	-
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	w						
	х						

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